Document Category: Product Specification



UltraCMOS® SPDT RF Switch, 10 MHz–40 GHz

Features

- Wideband support up to 40 GHz
- High port to port isolation
 - 48 dB @ 26.5 GHz
 - 39 dB @ 35 GHz
 - 33 dB @ 40 GHz
- Excellent linearity performance
 - P1dB of 31.5 dBm @ 26.5 GHz
 - P1dB of 28.0 dBm @ 35 GHz
 - IIP3 of 50 dBm @ 13.5 GHz
- Fast RF T_{rise}/T_{fall} time of 55 ns
- Low insertion loss
 - 1.8 dB @ 26.5 GHz
 - 3.1 dB @ 35 GHz
- Flip-chip die

Applications

- Test and measurement
- Microwave backhaul
- Radar
- Military communications

RF1 ESD V1 V2 RF2

Product Description

The PE42524 is a HaRP[™] technology-enhanced reflective SPDT RF switch die that supports a wide frequency range from 10 MHz to 40 GHz. This wideband flip-chip switch delivers high isolation performance, excellent linearity and low insertion loss, making this device ideal for test and measurement (T&M), microwave backhaul, radar and military communications (mil-comm) applications. At 30 GHz, the PE42524 exhibits 17 dB active port return loss, 47 dB isolation and 2.2 dB insertion loss. No blocking capacitors are required if DC voltage is not present on the RF ports.

The PE42524 is manufactured on pSemi's UltraCMOS[®] process, a patented variation of silicon-on-insulator (SOI) technology on a sapphire substrate.

pSemi's HaRP technology enhancements deliver high linearity and excellent harmonics performance. It is an innovative feature of the UltraCMOS process, offering the performance of GaAs with the economy and integration of conventional CMOS.

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Figure 1 • PE42524 Functional Diagram



Absolute Maximum Ratings

Exceeding absolute maximum ratings listed in **Table 1** may cause permanent damage. Operation should be restricted to the limits in **Table 2**. Operation between operating range maximum and absolute maximum for extended periods may reduce reliability.

ESD Precautions

When handling this UltraCMOS device, observe the same precautions as with any other ESD-sensitive devices. Although this device contains circuitry to protect it from damage due to ESD, precautions should be taken to avoid exceeding the rating specified in **Table 1**.

Latch-up Immunity

Unlike conventional CMOS devices, UltraCMOS devices are immune to latch-up.

Table 1 • Absolute Maximum Ratings for PE42524

Parameter/Condition	Min	Мах	Unit			
Control voltage (V1, V2)	-3.5	3.5	V			
RF input power (RFC–RFX, 50Ω)		Fig. 2	dBm			
Storage temperature range	-65	+150	°C			
ESD voltage HBM, all pins ^(*)		2000	V			
Note: * Human body model (MIL-STD883 Method 3015).						



Recommended Operating Conditions

Table 2 lists the recommended operating conditions for PE42524. Devices should not be operated outside the recommended operating conditions listed below.

Table 2 • Recommended Operating Condition for PE42524

Parameter	Min	Тур	Мах	Unit
Control high (V1, V2)	3.1	3.3	3.5	V
Control low (V1, V2)	-3.5	-3.3	-3.1	V
Control current		2		nA
RF input power, CW (RFC–RFX) ⁽¹⁾			Fig. 2	dBm
RF input power, pulsed (RFC–RFX) ⁽²⁾			Fig. 2	dBm
Operating temperature range	-40	+25	+85	°C
Notes: 1) 100% duty cycle, all bands, 50Ω. 2) Pulsed, 5% duty cycle of 4620 μs period, 50Ω.	<u>.</u>	<u>.</u>	<u>.</u>	

Electrical Specifications

Table 3 provides the PE42524 key electrical specifications @ 25 °C, V1 = +3.3V, V2 = -3.3V or V1 = -3.3V, V2 = +3.3V (Z_S = Z_L = 50 Ω), unless otherwise specified.

Table 3 • PE42524 Electrical Specifications

Parameter	Path	Condition	Min	Тур	Max	Unit
Operation frequency			10 MHz		40 GHz	As shown
		10 MHz		0.6	0.85	dB
		10 MHz–7.5 GHz		1.0	1.30	dB
		7.5–10 GHz		1.1	1.50	dB
		10–13.5 GHz		1.3	1.65	dB
Insertion loss	RFC-RFX	13.5–18 GHz		1.4	1.75	dB
		18–20 GHz		1.4	1.75	dB
		20–26.5 GHz		1.8	2.20	dB
		26.5–30 GHz		2.2	2.70	dB
		30–35 GHz		3.1	4.10	dB
		35–40 GHz		5.5	_	dB



Table 3 • PE42524 Electrical Specifications

Parameter	Path	Condition	Min	Тур	Max	Unit
Isolation	All paths	10 MHz 10 MHz–7.5 GHz 7.5–10 GHz 10–13.5 GHz 13.5–18 GHz 18–20 GHz 20–26.5 GHz 26.5–30 GHz 30–35 GHz	74 60 58 51 50 49 44 43 35	84 64 65 58 53 52 48 47 39		dB dB dB dB dB dB dB dB dB
Return loss (active port)	RFC-RFX	35–40 GHz 10 MHz 10 MHz–7.5 GHz 7.5–10 GHz 10–13.5 GHz 13.5–18 GHz 13.5–18 GHz 20–26.5 GHz 20–26.5 GHz 30–35 GHz 35–40 GHz	28	33 25 16 15 17 21 21 18 17 14 6		dB dB dB dB dB dB dB dB dB dB dB dB
Return loss (RFC port)	RFC-RFX	10 MHz 10 MHZ–7.5 GHz 7.5–10 GHz 10–13.5 GHz 13.5–18 GHz 18–20 GHz 20–26.5 GHz 26.5–30 GHz 30–35 GHz 35–40 GHz		25 18 19 26 29 23 31 30 16 7		dB dB dB dB dB dB dB dB dB dB
2nd harmonic, 2fo rejec- tion	RFC-RFX	+25 dBm output power, 1 GHz +25 dBm output power, 6.5 GHz +25 dBm output power, 15 GHz		88 84 >89 ⁽¹⁾		dBc dBc dBc
Input 1dB compression point ⁽²⁾		10 MHz–40 GHz		Fig. 2		dBm
Input IP3		10–100 MHz 1–2 GHz 6–10 GHz 10–13.5 GHz		48 50 52 50		dBm dBm dBm dBm
Video feedthrough ⁽³⁾		DC measurement		3.5		mV _{PP}
RF T _{rise} /T _{fall}		10%/90% RF		55		ns
Settling time		50% CTRL to 0.05 dB final value		0.84	1.13	μs



Table 3 • PE42524 Electrical Specifications

Parameter	Path	Condition		Тур	Max	Unit		
Switching time	50% CTRL to 90% or 10% RF 225 304					ns		
Notes: 1) Test system limited. 2) The input 1dB compression point is a linearity figure of merit. Refer to Table 2 for the RF input power (50Ω). 3) Measured with a 3.5 ns rise time, -3.3 / +3.3V pulse and 500 MHz bandwidth.								

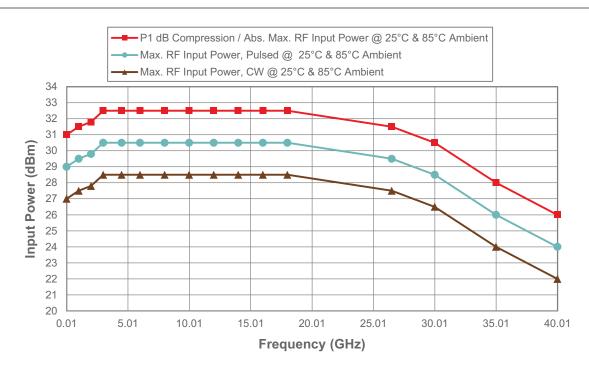
Control Logic

Table 4 provides the control logic truth table for the PE42524. States 2 and 3 are used in normal switching operations.

Table 4 🛛	Truth Table for	° PE42524
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V1	V2	RF1	RF2	State
-3.3V	-3.3V	OFF	OFF	1
-3.3V	+3.3V	OFF	ON	2
+3.3V	-3.3V	ON	OFF	3
+3.3V	+3.3V	ON	ON	4

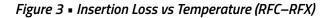
Figure 2 • Power De-rating Curve (10 MHz–40 GHz) @ 25 °C and 85 °C Ambient (50?)





Typical Performance Data

Figure 3–Figure 12 show the typical performance data @ 25 °C, V1 = +3.3V, V2 = -3.3V, unless otherwise specified.



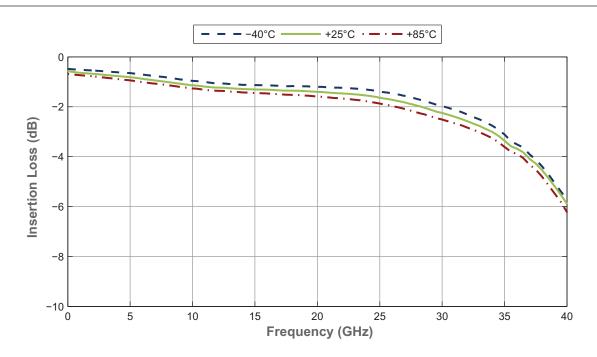


Figure 4 • Insertion Loss vs V1/V2 (RFC-RFX)

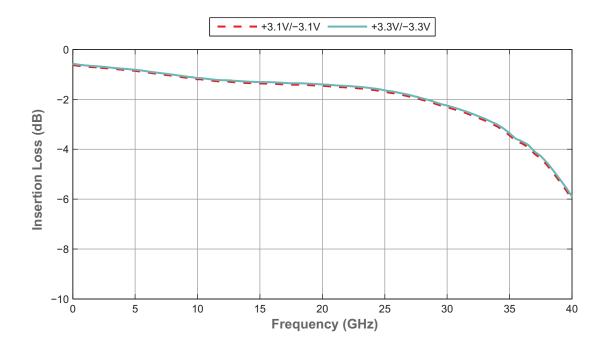




Figure 5 • RFC Port Return Loss vs Temperature

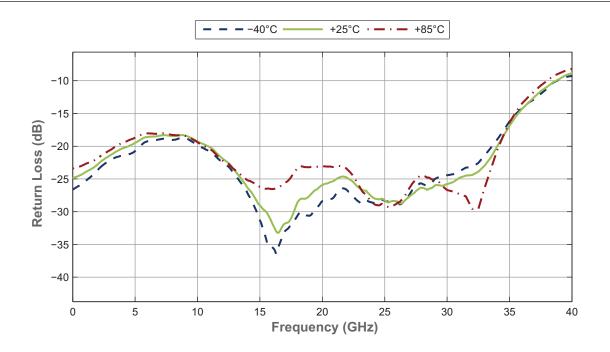
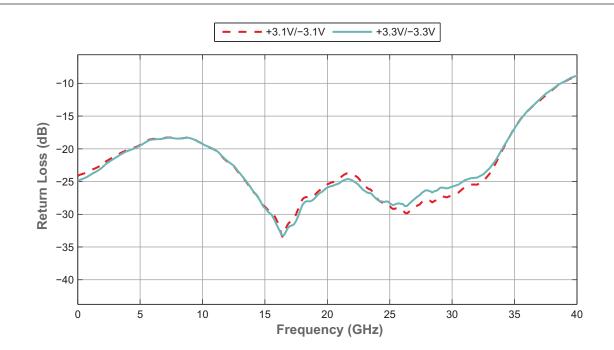


Figure 6 • RFC Port Return Loss vs V1/V2







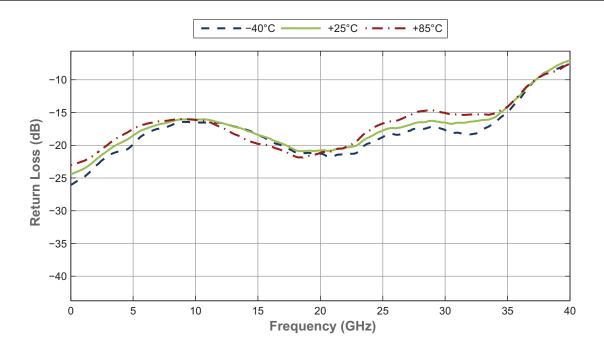


Figure 8 • Active Port Return Loss vs V1/V2

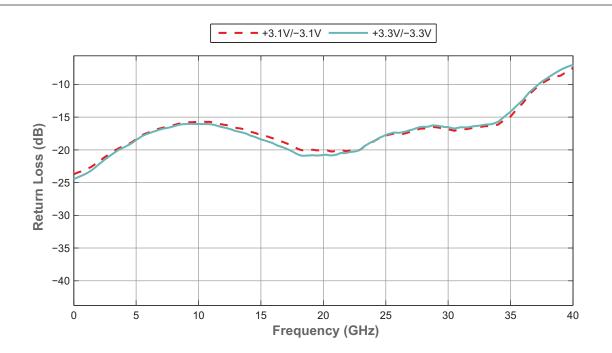




Figure 9 • Isolation vs Temperature (RFX-RFX)

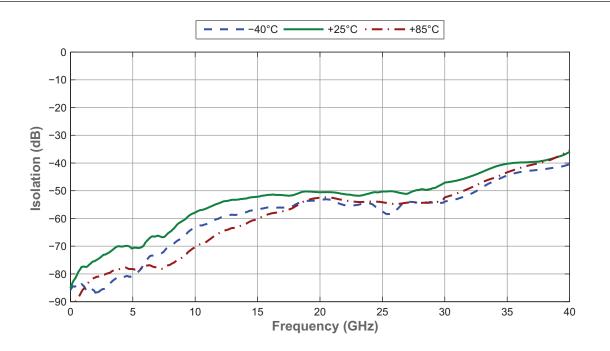


Figure 10 • Isolation vs V1/V2 (RFX-RFX)

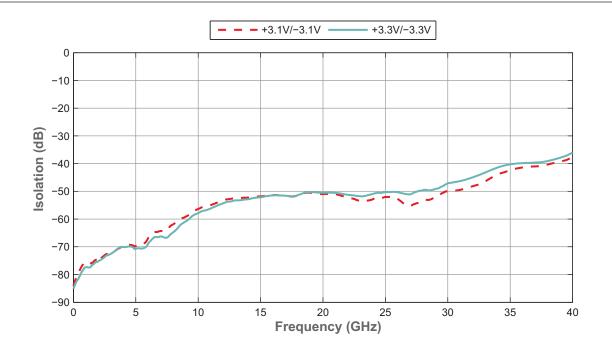




Figure 11 • Isolation vs Temperature (RFC-RFX)

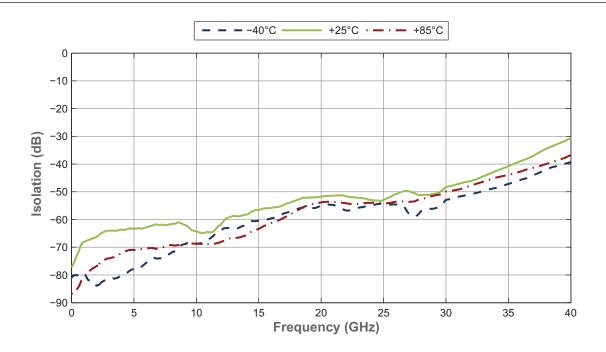
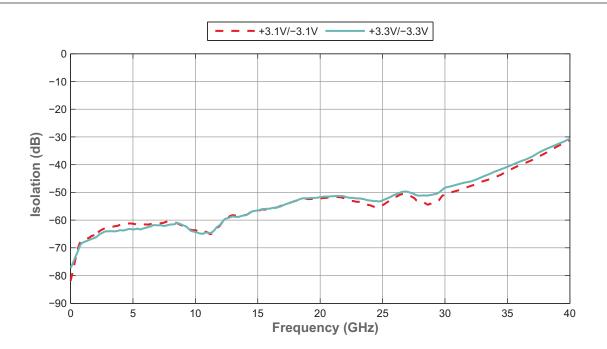


Figure 12 • Isolation vs V1/V2 (RFC-RFX)





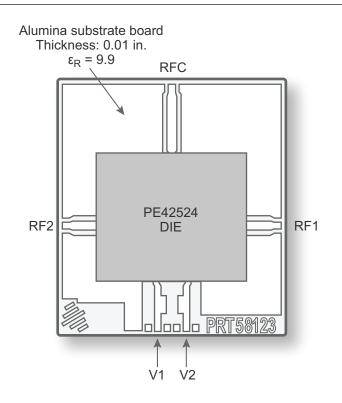
Recommended Evaluation Setup

The PE42524 s-parameter data and input 1dB compression point from 22–40 GHz (**Table 3** and **Figure 3–Figure 12**) were taken using grounded co-planar waveguide (CPWG) on the alumina substrate (shown in **Figure 13**) and RF probes.

The PE42524 2nd harmonic, 2fo rejection, input 1dB compression point below 18 GHz, input IP3 measurements, settling time and switching time (**Table 3**) were taken on a PCB using 2.92 mm connectors.

Bypass capacitors are not required.

Figure 13 • Alumina Substrate Board for PE42524





Pin Configuration

This section provides pin information for the PE42524. Figure 14 shows the pin configuration of this device. Table 5 provides a description for each pin.

Figure 14 • Pin Configuration (Bumps Up) (
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(9) GND	GND	RFC	GND 12	13 GND
GND ⑧	GN 18	D GNI	6	ND
RF1 ⑦	GN ①		RF2	
GN 6			GND ②	- 1
GND ⑤	V2 ④	V1		GND

Pin No.	Pin Name	Description	
1, 2, 5, 6, 8–10, 12–14, 16–19	GND	Ground	
7	RF1	RF port 1	
11	RFC	RF common port	
15	RF2	RF port 2	
3	V1	Control input 1	
4	V2	Control input 2	



Die Mechanical Specifications

This section provides the die mechanical specifications for the PE42524.

Table 6 • Mechanical Specifications for PE42524

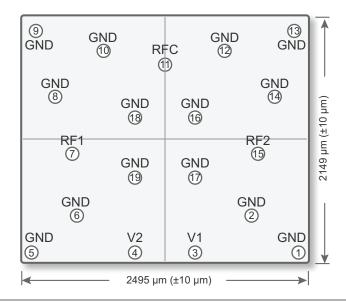
Parameter	Min	Тур	Max	Unit	Test Condition
Die size, singulated (x, y)	2466 × 2120	2486 × 2140	2516 × 2170	μm	Including excess sapphire, max. tolerance = –20 / +30 μm
Wafer thickness	180	200	220	μm	
Wafer size		150		mm	
Bump pitch	500			μm	
Bump height	72.5	85	97.75	μm	
Bump diameter		110		μm	
UBM diameter	85	90	95	μm	



Table 7 • Pin Coordinates for PE42524^(*)

Pin #	Pin Name	Pin Center (µm)		
		X	Y	
1	GND	1128.5	-958.5	
2	GND	731.5	-646.5	
3	V1	253.5	-958.5	
4	V2	-253.5	-958.5	
5	GND	-1128.5	-958.5	
6	GND	-731.5	-646.5	
7	RF1	-785.5	-121.5	
8	GND	-931.5	363.5	
9	GND	-1091.5	913.5	
10	GND	-503.5	753.5	
11	RFC	0	629	
12	GND	503.5	753.5	
13	GND	1091.5	913.5	
14	GND	931.5	363.5	
15	RF2	785.5	-121.5	
16	GND	253.5	183.5	
17	GND	253.5	-326.5	
18	GND	-253.5	183.5	
19	GND	-253.5	-326.5	
Note: * All pin locations originate from the die center and refer to the center of the pin.				

Figure 15 • *Pin Layout for PE42524*⁽¹⁾⁽²⁾



Notes:

1) Drawings are not drawn to scale.

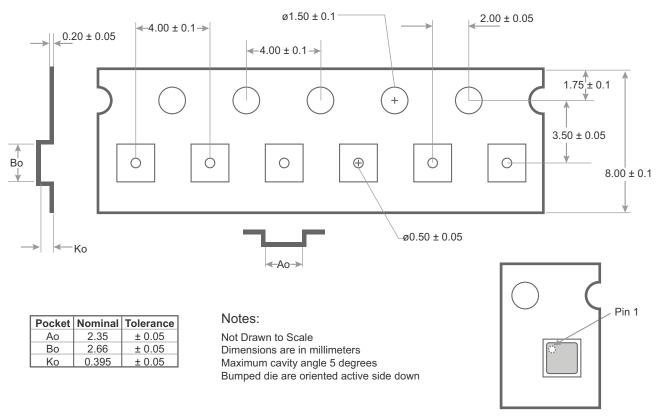
2) Singulated die size shown, bump side up.



Tape and Reel Specification

This section provides the tape and reel specifications for the PE42524.

Figure 16 • Tape and Reel Specifications for PE42524



Device Orientation in Tape



Ordering Information

Table 8 lists the available ordering code for the PE42524 as well as shipping method.

Table 8 • Order Code for PE42524

Order Code	Description	Packaging	Shipping Method
PE42524B-X	PE42524 SPDT RF switch	Die on tape and reel	500 die / T&R

Document Categories

Advance Information

The product is in a formative or design stage. The datasheet contains design target specifications for product development. Specifications and features may change in any manner without notice.

Preliminary Specification

The datasheet contains preliminary data. Additional data may be added at a later date. pSemi reserves the right to change specifications at any time without notice in order to supply the best possible product.

Product Specification

The datasheet contains final data. In the event pSemi decides to change the specifications, pSemi will notify customers of the intended changes by issuing a CNF (Customer Notification Form).

Product Brief

This document contains a shortened version of the datasheet. For the full datasheet, contact sales@psemi.com.

Sales Contact

For additional information, contact Sales at sales@psemi.com.

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